

QLF063A-85A0/QLF063D-85A0

685 nm 100mW FP LASER TO-CAN

Preliminary C00260-02 January 2024



1. DESCRIPTION

The QLF063A-85A0/QLF063D-85A0 are 685 nm quantum well laser devices designed for high output power application. The laser diode is mounted into a TO-56 header including a monitor PD and hermetic sealed with a flat glass cap.

2. FEATURES

- 685 nm FP-LD
- Φ5.6mm TO-CAN package
- High output power of 100mW and high slope efficiency
- Including monitor PD
- Two types of pin assignments: anode common type (QLF063A-85A0)/cathode common type (QLF063D-85A0)

3. APPLICATIONS

- Industrial laser markers
- Measuring instruments
- Life science applications

4. ABSOLUTE MAXIMUM RATING

(CW operation, $T_c = 25^{\circ}$ C, unless otherwise specified)

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PARAMETER	SYMBOL	RATING	UNIT		
Optical output power	Po	105	mW		
LD reverse voltage	V_{RLD}	2	V		
PD reverse voltage	V_{RPD}	30	V		
Operation temperature	T_{c}	-10 to 70	°C		
Storage temperature	T_{stg}	-40 to 85	°C		

QLF063A-85A0/QLF063D-85A0

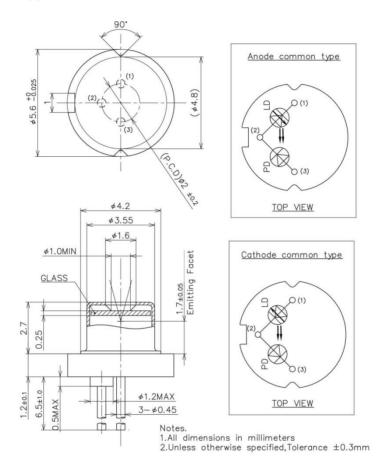
5. OPTICAL AND ELECTRICAL CHARACTERISTICS

 $(T_c = 25^{\circ}C, unless otherwise specified)$

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PARAMETER	SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNIT
Threshold current	I_{th}	CW	-	40	-	mA
Operation current	I_{op}	CW, P _o =100 mW	-	125	-	mA
Operation voltage	V_{op}	CW, P _o =100 mW	-	2.35	-	V
Slope efficiency	η	CW, P _o =5 - 100 mW	-	1.17	-	W/A
Monitor current	I_{m}	CW, P _o =100 mW,	-	220	-	μΑ
Peak wavelength	$\lambda_{ m p}$	CW, P _o =100 mW	680	685	690	nm
Beam divergence* Horizontal	θ_{h}	CW, P _o =100 mW	-	9	-	deg.
Beam divergence* vertical	$\theta_{ m v}$	CW, P _o =100 mW	-	14	-	deg.
Beam angle Horizontal	$\Delta heta_{ m h}$	CW, P _o =100 mW	-3	-	3	deg.
Beam angle vertical	$\Delta heta_{ m v}$	CW, P _o =100 mW	-3	-	3	deg.
	TT3					

^{*}Beam divergence is FWHM of far field pattern.

6. OUTLINE DRAWINGS



7. NOTICE

• Safety Information

This product is classified as Class 3B laser product, and complies with 21 CFR Part 1040.10.

Please do not take a look at laser lighting in operations since laser devices may cause troubles to human eyes. Please do not eat, burn, break and make chemical process of the products since they contain GaAs material.

Handling products

Semiconductor lasers are easily damaged by external stress such as excess temperature and ESD. Please pay attention to handling products, and use within range of maximum ratings. QD Laser takes no responsibility for any failure or unusual operation resulting from improper handling, or unusual physical or electrical stress.

RoHS

This product conforms to RoHS compliance related Directive (EU) 2015/863.

QD Laser, Inc.

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